# imall

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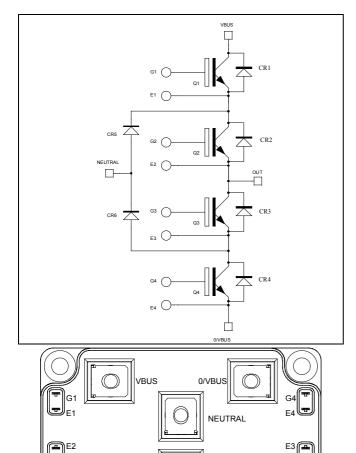
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## Three level inverter Trench + Field Stop IGBT3 Power Module



## $V_{CES} = 600V$ $I_C = 200A$ @ Tc = 80°C

#### Application

- Solar converter
- Uninterruptible Power Supplies

#### Features

- Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
  - Symmetrical design
  - M5 power connectors
  - High level of integration

#### Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant

#### Q1 to Q4 Absolute maximum ratings

OUT

G2

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage		600	V
т	Continuous Collector Current	$T_C = 25^{\circ}C$	300	
$I_{\rm C}$ Continuous Collector Current $\frac{1}{7}$	$T_C = 80^{\circ}C$	200	Α	
I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	400	
$V_{GE}$	Gate – Emitter Voltage		$\pm 20$	V
PD	Maximum Power Dissipation	$T_C = 25^{\circ}C$	652	W
RBSOA	Reverse Bias Safe Operating Area	$T_{j} = 150^{\circ}C$	400A @ 550V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



## All ratings @ $T_j = 25^{\circ}C$ unless otherwise specified

## Q1 to Q4 Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$				350	μA
V	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		1.5	1.9	V
V <sub>CE(sat)</sub>		$I_{\rm C} = 200 {\rm A}$	$T_{j} = 150^{\circ}C$		1.7		v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 3 \text{ mA}$		5.0	5.8	6.5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				800	nA

### Q1 to Q4 Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		12.2		
Coes	Output Capacitance	$V_{CE} = 25V$		0.78		nF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1MHz		0.38		
Q <sub>G</sub>	Gate charge	V <sub>GE</sub> =±15V, I <sub>C</sub> =200A V <sub>CE</sub> =300V		2.2		μC
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C)		115		
T <sub>r</sub>	Rise Time	$V_{GE} = \pm 15V$		45		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 300V$ $I_{C} = 200A$		225		ns
$T_{\rm f}$	Fall Time	$R_G = 1.8\Omega$		55		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (150°C)		130		ns
T <sub>r</sub>	Rise Time	$V_{GE} = \pm 15V$		50		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 300V$ $I_{C} = 200A$		300		
T <sub>f</sub>	Fall Time	$R_G = 1.8\Omega$		70		
Eon	Turn on Energy	$V_{GE} = \pm 15V$ $T_j = 25^{\circ}C$		0.8		mJ
Lon	Turn on Energy	$V_{Bus} = 300V$ $T_j = 150^{\circ}C$		1.75		1115
Б	Town off Francisco	$I_C = 200A$ $T_j = 25^{\circ}C$		5		
E <sub>off</sub>	Turn off Energy	$R_G = 1.8\Omega \qquad T_j = 150^{\circ}C$		7		mJ
I <sub>sc</sub>	Short Circuit data	$V_{GE} \le 15V$ ; $V_{Bus} = 360V$ $t_p \le 6\mu s$ ; $T_1 = 150^{\circ}C$		1000		А
R <sub>thJC</sub>	Junction to Case Thermal Resistance				0.23	°C/W



**CR1 to CR4 diode ratings and characteristics** 

Symbol	Characteristic		Test Conditions		Тур	Max	Unit	
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			600			V	
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =600V	$T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$			150 400	μA	
I <sub>F</sub>	DC Forward Current		$T_1 = 100 \text{ C}$ $T_2 = 80^{\circ}\text{C}$		150	400	А	
V <sub>F</sub>	Diode Forward Voltage	$I_{\rm F} = 150 {\rm A}$	$T_i = 25^{\circ}C$		1.6	2	V	
ν <sub>F</sub>	Diode Forward Voltage	$V_{GE} = 0V$	$V_{GE} = 0V$	$T_{i} = 150^{\circ}C$		1.5		v
+	Reverse Recovery Time		$T_j = 25^{\circ}C$		100		ns	
t <sub>rr</sub>	Reverse Recovery Time		$T_{j} = 150^{\circ}C$		150		115	
0	Reverse Recovery Charge	$I_{\rm F} = 150 {\rm A}$ $V_{\rm R} = 300 {\rm V}$	$T_j = 25^{\circ}C$		7.2		μC	
Q <sub>rr</sub>	$V_R = 500V$ di/dt = 2800A/µs $T_j = 150^{\circ}C$			$T_{j} = 150^{\circ}C$		15.2		μ
Б			$T_j = 25^{\circ}C$		1.7		m I	
E <sub>rr</sub>	Reverse Recovery Energy		$T_{j} = 150^{\circ}C$		3.6		mJ	
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.52	°C/W	

#### CR5 & CR6 diode ratings and characteristics

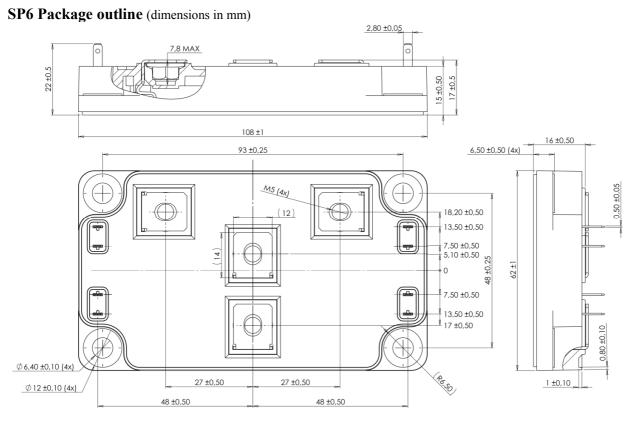
Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			600			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =600V	$T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$			150 400	μΑ
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		200		Α
V <sub>F</sub>	Diode Forward Voltage	$I_{\rm F} = 200 {\rm A}$ $V_{\rm GE} = 0 {\rm V}$	$T_i = 25^{\circ}C$		1.6	2	V
V F	Didde Forward Voltage		$T_{i} = 150^{\circ}C$		1.5		v
t <sub>rr</sub>	Reverse Recovery Time		$T_j = 25^{\circ}C$		125		ns
۲r	Reverse Recovery Time		$T_{j} = 150^{\circ}C$		220		115
0	Pavarsa Pacovary Charge	$I_{\rm F} = 200 \text{A}$ $V_{\rm R} = 300 \text{V}$	$T_j = 25^{\circ}C$		9.4		чС
Qrr	$Q_{rr}$ Reverse Recovery Charge $V_R = 300V_{di/dt} = 2800A/\mu s$	$T_{i} = 150^{\circ}C$		19.8		μC	
Б	D		$T_j = 25^{\circ}C$		2.2		mI
E <sub>rr</sub>	Reverse Recovery Energy		$T_{j} = 150^{\circ}C$		4.8		mJ
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.39	°C/W

#### Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit		
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V		
T <sub>J</sub>	Operating junction temperature range			-40		175			
T <sub>STG</sub>	Storage Temperature Range			-40		125	°C		
T <sub>C</sub>	Operating Case Temperature	perating Case Temperature				100			
Torque	Mounting torque	To heatsink	M6	3		5	N.m		
Torque	For termi		M5	2		3.5	19.111		
Wt	Package Weight					300	g		

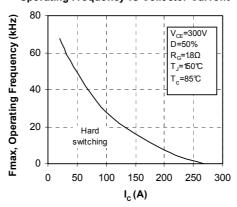
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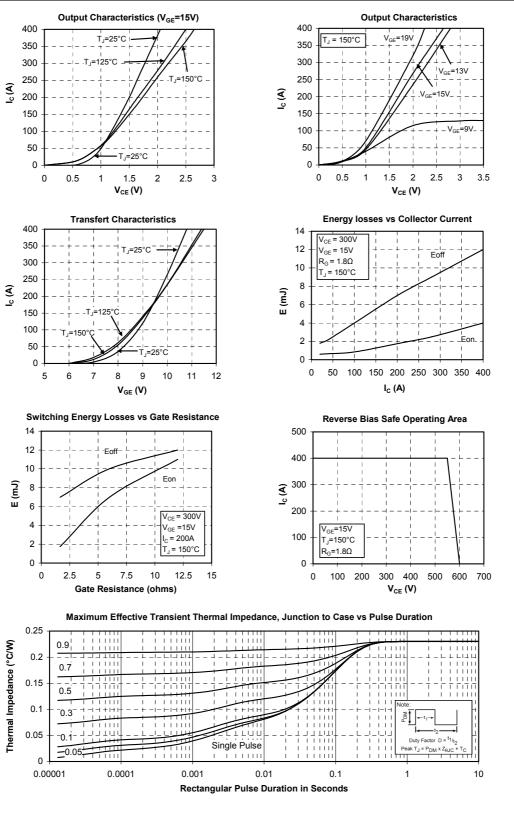
See application note APT0601 - Mounting Instructions for SP6 Power Modules on www.microsemi.com

#### Q1 to Q4 Typical performance curve



#### **Operating Frequency vs Collector Current**



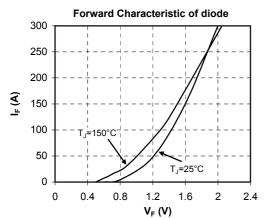


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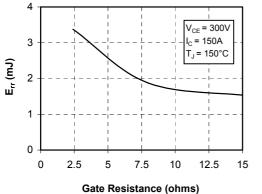
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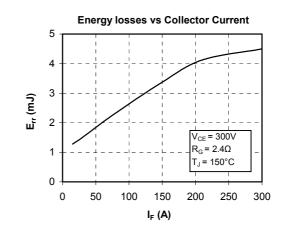


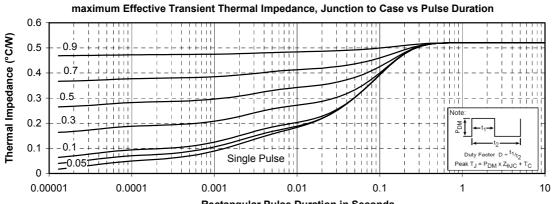
#### **CR1 to CR4 Typical performance curve**







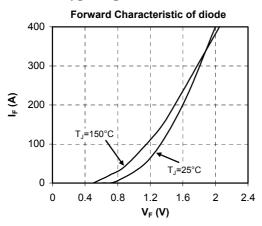




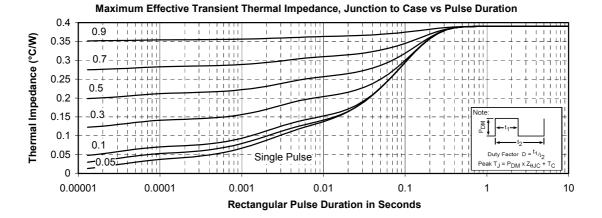
**Rectangular Pulse Duration in Seconds** 



#### CR5 & CR6 Typical performance curve



Switching Energy Losses vs Gate Resistance **Energy losses vs Collector Current** 8 5 V<sub>CE</sub> = 300V V<sub>CE</sub> = 300V R<sub>G</sub> = 1.8 Ω I<sub>C</sub> = 200A 4 T<sub>.</sub> = 150°C 6 T<sub>J</sub> = 150°C E<sub>rr</sub> (mJ) 3 E<sub>rr</sub> (mJ) 4 2 2 1 0 0 0 100 200 300 0 2.5 5 7.5 10 12.5 15  $I_F(A)$ Gate Resistance (ohms)



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